
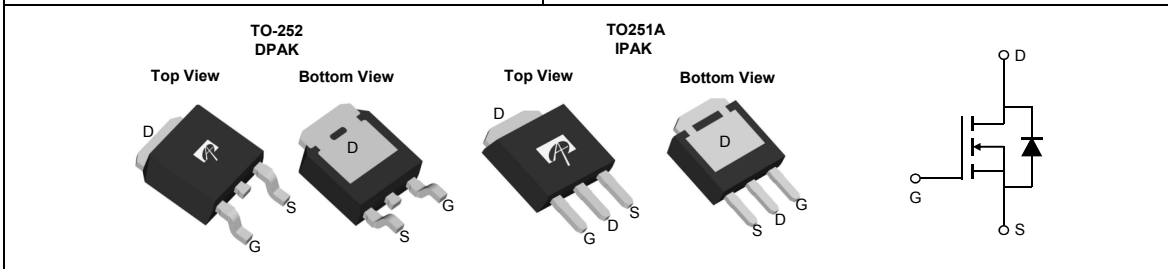


<p>General Description</p> <ul style="list-style-type: none"> Trench Power MV MOSFET technology Low $R_{DS(ON)}$ Low Gate Charge Optimized for fast-switching applications <p>Applications</p> <ul style="list-style-type: none"> Synchronous Rectification in DC/DC and AC/DC Converters Industrial and Motor Drive applications 	<p>Product Summary</p> <table border="0"> <tr> <td>V_{DS}</td> <td>200V</td> </tr> <tr> <td>I_D (at $V_{GS}=10V$)</td> <td>18A</td> </tr> <tr> <td>$R_{DS(ON)}$ (at $V_{GS}=10V$)</td> <td>< 105mΩ</td> </tr> <tr> <td>$R_{DS(ON)}$ (at $V_{GS}=5V$)</td> <td>< 120mΩ</td> </tr> </table> <p>100% UIS Tested 100% Rg Tested</p> 	V_{DS}	200V	I_D (at $V_{GS}=10V$)	18A	$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 105m Ω	$R_{DS(ON)}$ (at $V_{GS}=5V$)	< 120m Ω
V_{DS}	200V								
I_D (at $V_{GS}=10V$)	18A								
$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 105m Ω								
$R_{DS(ON)}$ (at $V_{GS}=5V$)	< 120m Ω								



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOD2210	TO-252	Tape & Reel	2500
AOI2210	TO-251A	Tube	4000

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	200	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	18
		$T_C=100^\circ\text{C}$	13
Pulsed Drain Current ^C	I_{DM}	45	A
Continuous Drain Current	I_{DSM}	$T_A=25^\circ\text{C}$	3.0
		$T_A=70^\circ\text{C}$	2.5
Avalanche Current ^C	I_{AS}	9	A
Avalanche energy $L=0.1\text{mH}$ ^C	E_{AS}	4	mJ
V_{DS} Spike	V_{SPIKE}	240	V
Power Dissipation ^B	P_D	$T_C=25^\circ\text{C}$	100
		$T_C=100^\circ\text{C}$	50
Power Dissipation ^A	P_{DSM}	$T_A=25^\circ\text{C}$	2.5
		$T_A=70^\circ\text{C}$	1.6
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A $t \leq 10\text{s}$	$R_{\theta JA}$	15	20	$^\circ\text{C/W}$
Maximum Junction-to-Ambient ^{A,D} Steady-State		41	50	$^\circ\text{C/W}$
Maximum Junction-to-Case Steady-State	$R_{\theta JC}$	1	1.5	$^\circ\text{C/W}$

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	200			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =200V, V _{GS} =0V T _J =55°C			1 5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.5	2.0	2.5	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =18A T _J =125°C		87	105	mΩ
		V _{GS} =5V, I _D =16A		93	120	
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =18A		40		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.7	1	V
I _S	Maximum Body-Diode Continuous Current				18	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		2065		pF
C _{oss}	Output Capacitance			74		pF
C _{riss}	Reverse Transfer Capacitance			3.8		pF
R _g	Gate resistance	f=1MHz	1.1	2.2	3.3	Ω
SWITCHING PARAMETERS						
Q _{g(10V)}	Total Gate Charge	V _{GS} =10V, V _{DS} =100V, I _D =18A		27	40	nC
Q _{g(4.5V)}	Total Gate Charge			12	20	nC
Q _{gs}	Gate Source Charge			7		nC
Q _{gd}	Gate Drain Charge			3		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =100V, R _L =5.5Ω, R _{GEN} =3Ω		8		ns
t _r	Turn-On Rise Time			10		ns
t _{D(off)}	Turn-Off DelayTime			30		ns
t _f	Turn-Off Fall Time			4		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =18A, dI/dt=500A/μs		60		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =18A, dI/dt=500A/μs		800		nC

A. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The Power dissipation P_D is based on R_{θJA} ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T_{J(MAX)}=175° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

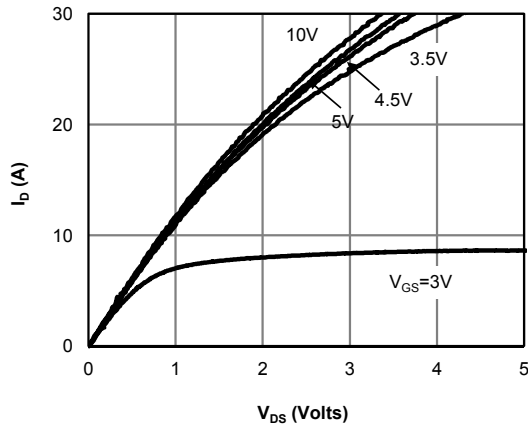


Figure 1: On-Region Characteristics (Note E)

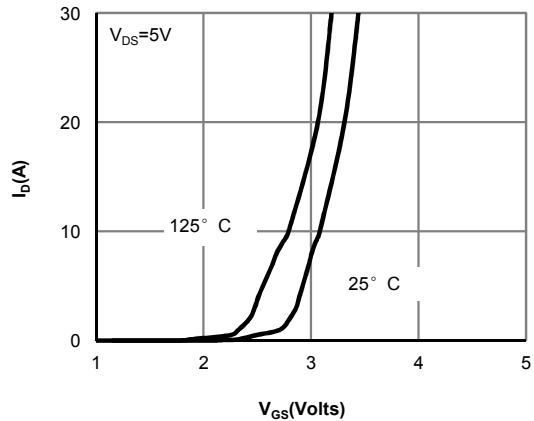


Figure 2: Transfer Characteristics (Note E)

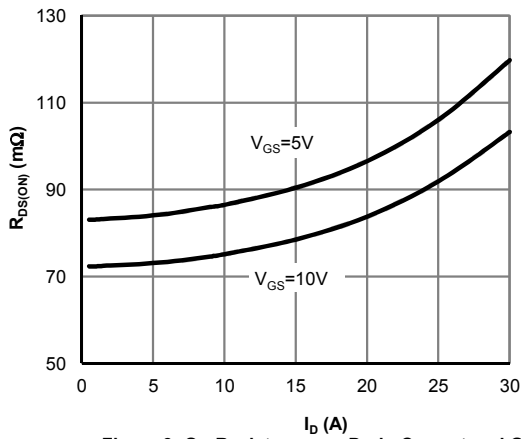


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

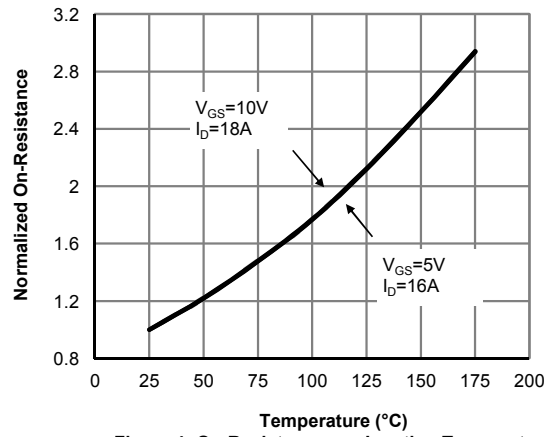


Figure 4: On-Resistance vs. Junction Temperature (Note E)

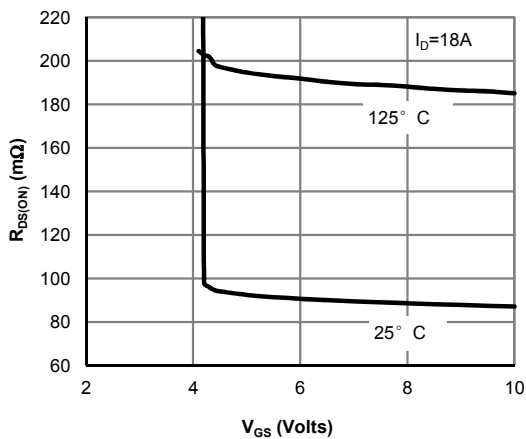


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

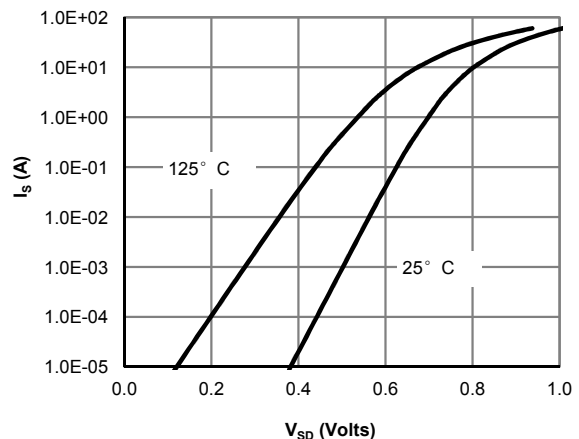


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

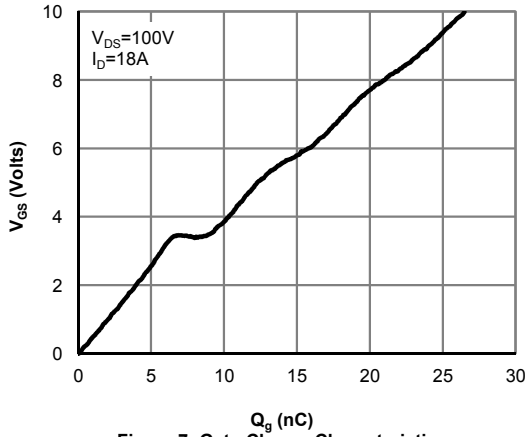


Figure 7: Gate-Charge Characteristics

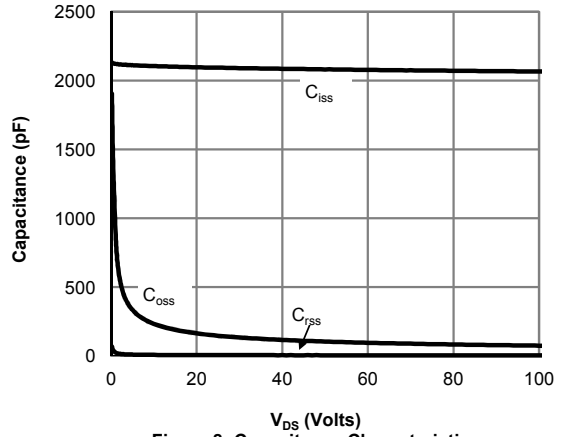


Figure 8: Capacitance Characteristics

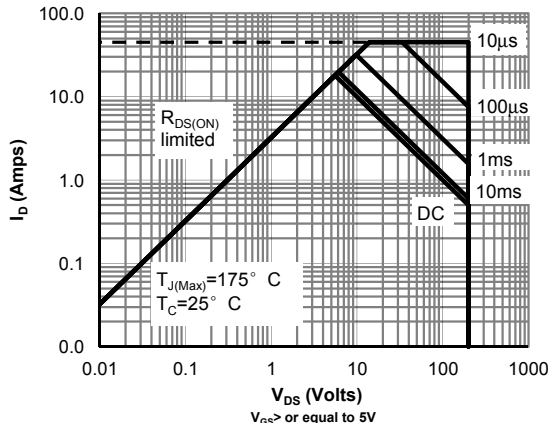


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

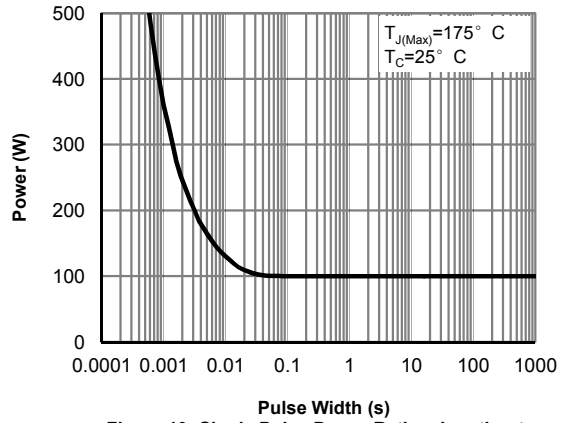


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

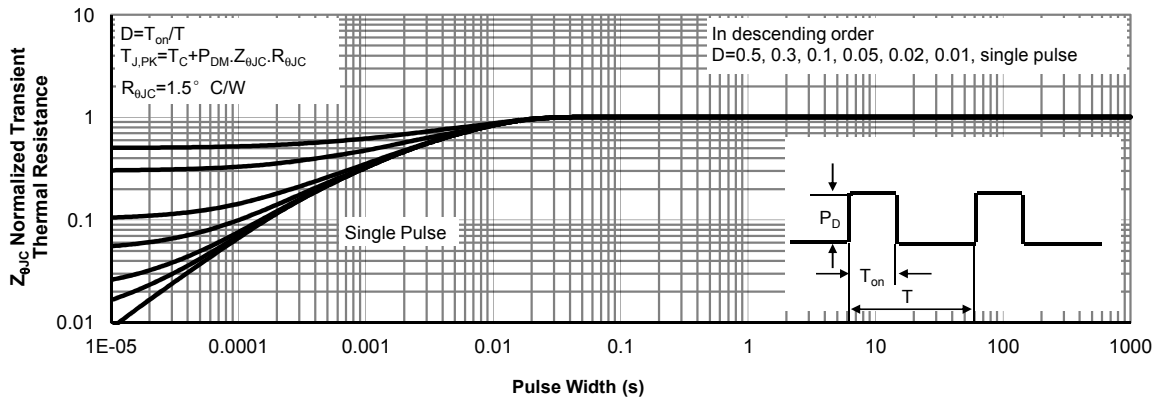


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

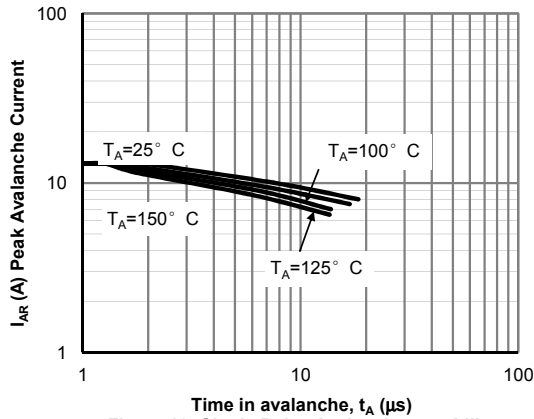


Figure 12: Single Pulse Avalanche capability (Note C)

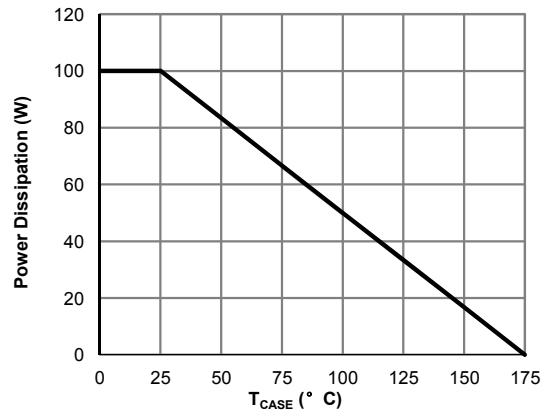


Figure 13: Power De-rating (Note F)

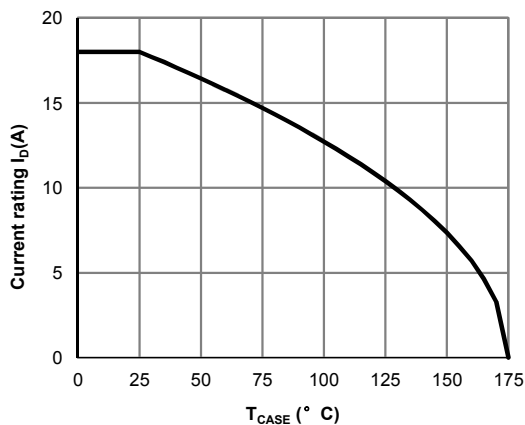


Figure 14: Current De-rating (Note F)

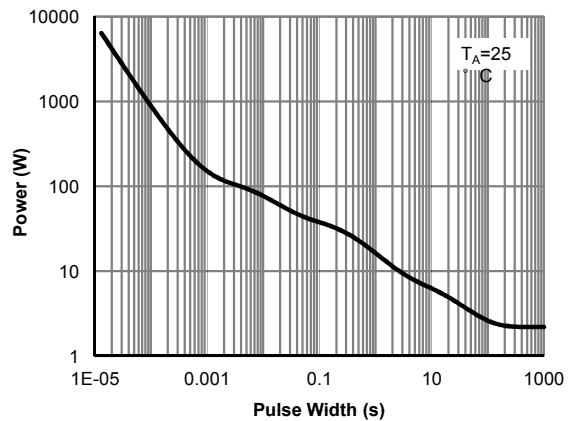


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

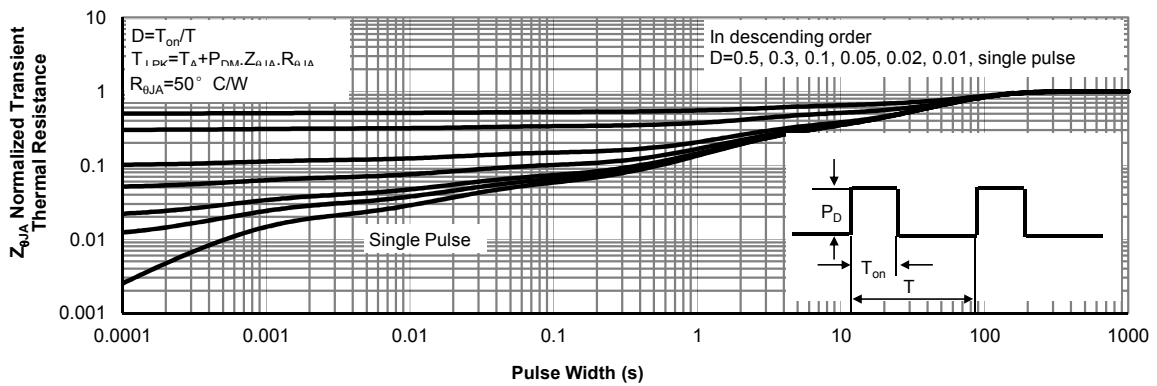
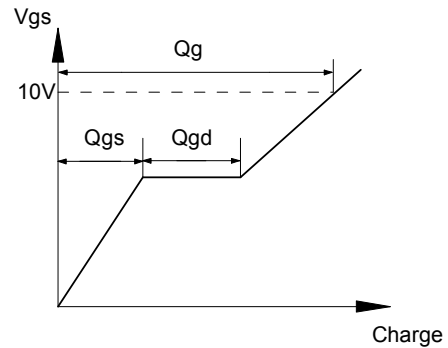
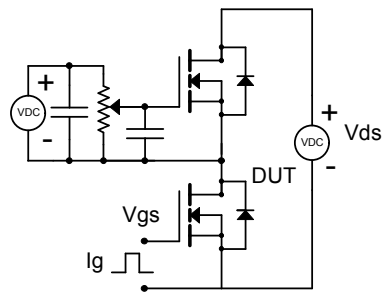
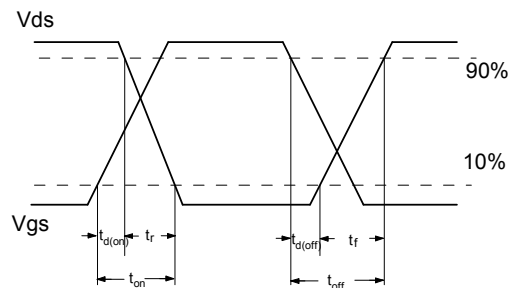
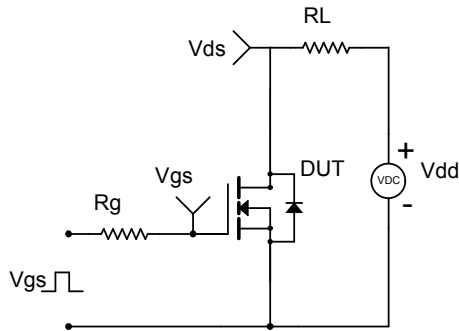


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

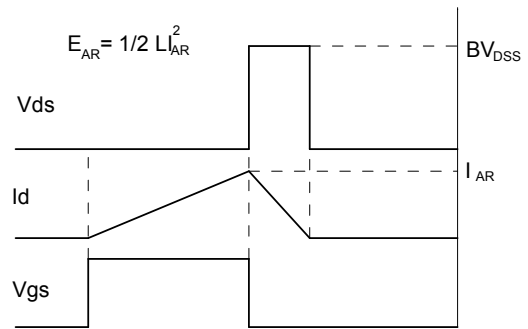
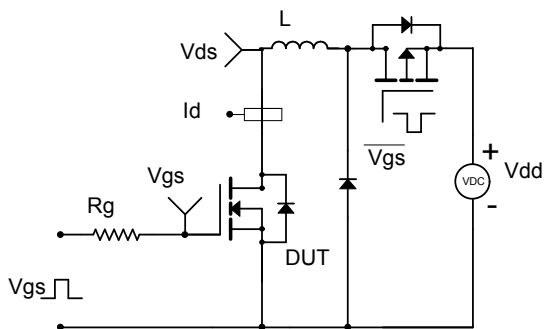
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

